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PTO/SB/08a/b (08-03)

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Substitute for form 1449A/B/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet

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of

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Complete If Known	
Application Number	Not Yet Assigned 117266955
Filing Date	Concurrently Herewith
First Named Inventor	Aurelie Falcou
Art Unit	N/A
Examiner Name	Not Yet Assigned
Attorney Docket Number	09931-00037-US

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
B3D	AA	US-4,326,989	04-27-1982	Colon et al.	
	AB	US-5,679,760	10-21-1997	Mullen et al.	
	AC	US-5,712,361	01-27-1998	Stern et al.	
	AD	US-5,763,636	06-09-1998	Kreuder et al.	
	AE	US-5,856,434	01-05-1999	Stern et al.	
	AF	US-6,361,884	03-26-2002	Kreuder et al.	
	AG	US-6,653,438	11-25-2003	Spreitzer et al.	
	AH	US-2005/0038223	02-17-2005	Becker et al.	

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T*
		Country Code ³ -Number- Kind Code ⁴ (if known)				
B3D	BA	JP-52-154900	12-22-1977	Tokyo Inst Technology		See abstract
R3D	BB	EP-0 012 201	06-25-1980	Amoco Corporation		
R3D	BC	EP-0 025 460	03-25-1981	Amoco Corporation		
R3D	BD	JP-61-233014	10-17-1986	Yamamoto Ryuichi		See abstract
B3D	BE	JP-2008213	01-11-1990	Yamamoto Ryuichi		See abstract
B3D	BF	WO-90/06295	06-14-1990	Eastman Kodak Company		
B3D	BG	WO-92/18552	10-29-1992	Wacker-Chemie GmbH		See US 5,679,760
B3D	BH	WO-95/07955	03-23-1995	Hoechst AG		See US 5,856,434
B3D	BI	EP-0 690 086	01-03-1996	Hoechst AG		See US 5,712,361
B3D	BJ	WO-96/39455	12-12-1996	Maxdem Inc.		
B3D	BK	WO-97/31048	08-28-1997	Hoechst AG		See US 6,361,884
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B3D	BM	EP-0 842 208	05-20-1998	The Dow Chemical Company		
R3D	BN	WO-98/33836	08-06-1998	JSR Corporation		
B3D	BQ	WO-99/54385	10-28-1999	The Dow Chemical Company		
B3D	BP	WO-00/22026	04-20-2000	Axiva GmbH		See US 6,653,438
B3D	BQ	WO-00/46321	08-10-2000	The Dow Chemical Company		
B3D	BR	WO-00/55927	09-21-2000	Cambridge Display Technology Limited		
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Examiner Signature		Date Considered	3/28/07
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Substitute for form 1449A/B/PTO				Complete If Known	
				Application Number	10/526955
				Filing Date	March 7, 2005
				First Named Inventor	Aurelie Falcou
				Art Unit	N/A
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	09931-00037-US

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		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)			

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NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T ⁶
Bob	CA	Marsitzky et al., "Self-Encapsulation of Poly-2,7-fluorenes in a Dendrimer Matrix", <i>J. Am. Chem. Soc.</i> , Vol. 123, No. 29, pp. 6965-6972 (2001).			

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